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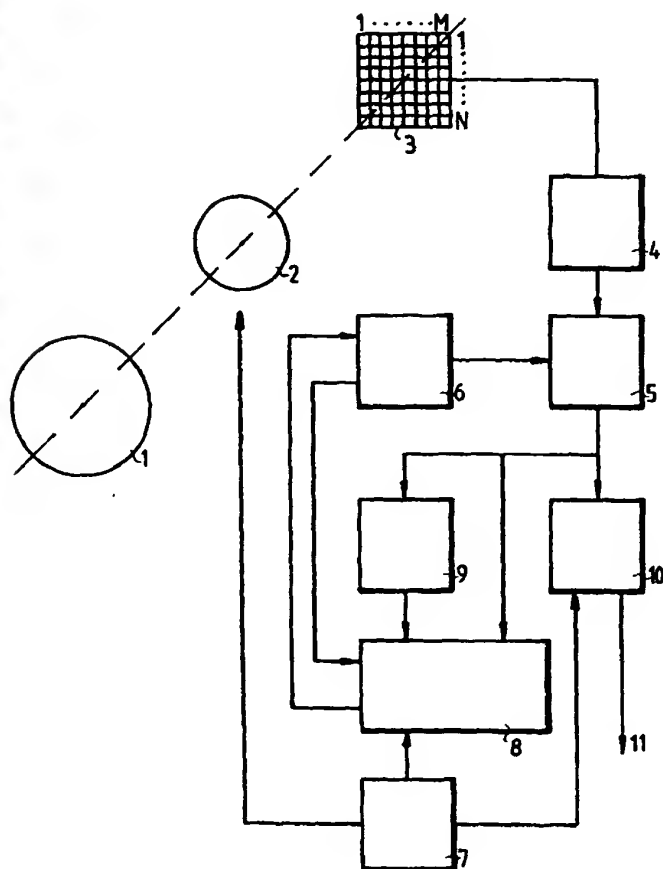
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(54) Title: DETECTION ARRANGEMENT PROVIDED WITH OFFSET COMPENSATION



(57) Abstract: Offset arrangement for an infrared detector array, which continuously adjusts the offset in a recursive process. With the aid of a displacement device the image observed by the detector array is continuously shifted over a small distance, the apparent intensity changes arising for a pixel being used for adjusting the offset.

WO 01/28233 A1